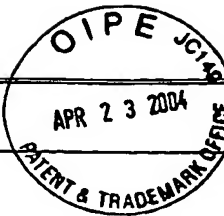


Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
247973US2SERIAL NO.
10762,476

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Naoto SHIRAISHIFILING DATE
January 23, 2004

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
A.C.	AA	2003/0063813	4/3/2003	Naoto SHIRAISHI; Appl. No. 10/127,553; Filed 4/23/2002	—	—	
A.C.	AB	2003/0053701	3/20/2003	Naoto SHIRAISHI; Appl. No. 10/100,776; Filed 3/19/2002	—	—	
A.C.	AC	5,903,276	5/11/1999	Naoto SHIRAISHI	—	—	
A.C.	AD	5,828,378	10/27/1998	Naoto SHIRAISHI	—	—	
A.C.	AE	6,172,678	1/9/2001	Naoto SHIRAISHI	—	—	
A.C.	AF	5,732,204	3/24/1998	Masanobu FUKUSHIMA, et al.	—	—	
A.C.	AG	5,448,690	9/5/1995	Naoto SHIRAISHI, et al.	—	—	
A.C.	AH	5,551,019	8/27/1996	Yasuhiro IZAWA, et al.	—	—	
A.C.	AI	5,455,900	10/3/1995	Naoto SHIRAISHI, et al.	—	—	
A.C.	AJ	5,739,826	4/14/1998	Naoto SHIRAISHI, et al.	—	—	
A.C.	AK	5,459,822	10/17/1995	Yasuhiro IZAWA, et al.	—	—	
A.C.	AL	5,337,168	8/9/1994	Tatsuya FUJII, et al.	—	—	
A.C.	AM	5,465,371	11/7/1995	Tatsuya FUJII, et al.	—	—	
A.C.	AN	5,396,585	3/7/1995	Tatsuya FUJII, et al.	—	—	
A.C.	AO	5,341,468	8/23/1994	Naoto SHIRAISHI, et al.	—	—	
A.C.	AP	5,859,650	1/12/1999	Naoto SHIRAISHI	—	—	
A.C.	AQ	6,081,274	6/27/2000	Naoto SHIRAISHI	—	—	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Ant. Ch.

Date Considered

3/4/05

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 247973US2		SERIAL NO. 10/762,476	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Naoto SHIRAIISHI			
				FILING DATE January 23, 2004		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<i>A.c.</i>	AO	11-99701	04/13/1999	JAPAN (with English Abstract)			X
<i>A.c.</i>	AP	9-190538	07/22/1997	JAPAN (with English Abstract)			X
<i>A.c.</i>	AQ	2001-101431	04/13/2001	JAPAN (with English Abstract)			X
<i>A.c.</i>	AR	11-15997	01/22/1999	JAPAN (with English Abstract)			X
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	AT						
	AU						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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Examiner <i>Auto Col</i>					Date Considered <i>3/8/05</i>		
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